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Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
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Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
- 4) Click Search. See [Search Examples](#)

((profile or function or model or curve) <near/4> fit) and (ct or (computed <near/1> tomograph) or tomograph)

Note: This function returns plural and suffixed forms of the keyword(s).

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